Date Created: 2008/01/25 Date Issued On: 2008/03/17

PCN#: **Q4074601-A** 

#### DESIGN/PROCESS CHANGE NOTIFICATION -- FINAL

This is to inform you that a design and/or process change will be made to the following product(s). This notification is for your information and concurrence.

If you require data or samples to qualify this change, please contact Fairchild Semiconductor within 30 days of receipt of this notification.

Updated process quality documentation, such as FMEAs and Control Plans, are available for viewing upon request.

If you have any questions concerning this change, please contact:

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Implementation of change:

Expected 1st Device Shipment Date: 2008/03/20

Earliest Year/Work Week of Changed Product: 0813

Change Type Description: Mold Compound

Description of Change (From): 8L MLP3x3 package assembly at all FSC approved manufacturing location(s) (Carsem) using non Green mold compound as shown in table 1.

Description of Change (To): 8L MLP 3x3 package assembly at all FSC approved manufacturing location(s) (Carsem) using Green mold compound as shown in table 2.

Reason for Change: Green initiative by Fairchild Semiconductor. Fairchild Semiconductor is dedicated to being a good corporate citizen. All Fairchild Semiconductor products are 2nd level interconnect lead-free and RoHS compliance. The referenced material changes have been made to provide a 'Full Green' (Halogen Free Flame Retardant) package. For additional details on the corporate wide green initiative please visit our Web site at:

http://www.fairchildsemi.com/company/green/index.html Manufacturing will occur at the same assembly facilities producing the current non-green products. Package outline drawings of the affected products remain un-changed. Green products will be fully compliant to all published data sheet specifications and will be interchangeable with current non-green product. Quality and reliability will remain at the highest standards already demonstrated with Fairchild's existing products.

Qual/REL Plan Numbers: Q20070296

#### Qualification:

All the reliability tests defined in this qual plan completed with no failures. Therefore Carsem is qualified to assemble MLP 3x3 8L package.

# Change From

Table 1:

Assembly Site	Carsem	
Lead Frame	DCI C194 with Ag Plated	
Die Attach	84-1LMISNB	
Wire	2 mils Au	
Mold Compound	MP8000CSM-F1	
Lead Finish	Tin plating (matte finish)	

# Change To

Table 2:

Assembly Site	Carsem	
Lead Frame	DCI C194 with Ag Plated	
Die Attach	84-1LMISNB	
Wire	2 mils Au	
Mold Compound	G600	
Lead Finish	Tin plating (matte finish)	

# **Results/Discussion**

Test: (Autoclave)				
Lot	Device	96-HOU	RS	Failure Code
Q20070296BAACLV	FDMC2674	0/77		
Q20070296CAACLV	FDMC8854	0/77		
Test: (High Tempera	ture Gate Bias)			
Lot	Device	500-HOURS	1000-HOURS	Failure Code
Q20070296BAHTGB	FDMC2674	0/77		
Q20070296BAHTGB	FDMC2674		0/77	
Q20070296CAHTGB	FDMC8854	0/77		
Q20070296CAHTGB	FDMC8854		0/77	
Test: (High Tempera	ture Reverse Bias)			
Lot	Device	500-HOURS	1000-HOURS	Failure Code
Q20070296BAHTRB	FDMC2674	0/77		
Q20070296BAHTRB	FDMC2674		0/77	
Q20070296CAHTRB	FDMC8854	0/77		
Q20070296CAHTRB	FDMC8854		0/77	
Test: (Power Cycle)				
Lot	Device	5000-CYCLES	10000-CYCLES	Failure Code
Q20070296AAPRCL	FDM6296	0/77		
Q20070296AAPRCL	FDM6296		0/77	
Q20070296BAPRCL	FDMC2674	0/77		
Q20070296BAPRCL	FDMC2674		0/77	
Q20070296CAPRCL	FDMC8854	0/77		
Q20070296CAPRCL	FDMC8854		0/77	
Test: -65C, 150C (Te	emperature Cycle)			
Lot	Device	100-CYCLES	500-CYCLES	Failure Code

Q20070296AATMCL1	FDM6296	0/77			
Q20070296AATMCL1	FDM6296		0/77		
Q20070296BATMCL1	FDMC2674	0/77			
Q20070296BATMCL1	FDMC2674		0/77		
Q20070296CATMCL1	FDMC8854	0/77			
Q20070296CATMCL1	FDMC8854		0/77		
Test: 110C (Highly Acc	celerated Stress Tes	t)	·	·	
Lot	Device	264-	HOURS	Failure Code	
Q20070296AAHAST2	FDM6296	0/77	,		
Q20070296BAHAST2	FDMC2674	0/77			
Q20070296CAHAST2	FDMC8854	0/77			
Test: MSL(1), PKG(Sn	nall), PeakTemp(260	c), Cycles(3) (Pre	condition)		
Lot	Device	Resi	ults	Failure Code	
Q20070296AAPCNL1A	FDM6296	0/15	4		
Q20070296BAPCNL1A	FDMC2674	0/23	1		
Q20070296CAPCNL1A	FDMC8854	0/23	1		

Product Id Description: This Final PCN covers Fairchild Semiconductor MLP3x3 8L packages. For a complete listing of products covered in this PCN release, please refer to the affected FSID listing.

#### Affected FSIDs:

FDM3300NZ	FDM3300NZ_NL	FDM3622
FDM3622_NL	FDM6296	FDM6296_NL
FDMC2523P	FDMC2610	FDMC2674
FDMC3300NZA	FDMC5614P	FDMC8554
FDMC8854	FDMC8878	FDMC8878_NBSE003